Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/065,452	WANG, CHUNG-E	
Examiner	Art Unit	
Ellen C. Tran	2134	

	SEAR	CHED	
Class	Subclass	Date	Examiner
380	269	4/9/2006	ECT
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	4/9/2006	ECT